INFC	CIT	ATION DISCLO FATION IN AN PPLICATION	ATTY, DOCKET NO. 061282-0055		SERIAL NO. 10/757,388					
				APPLICANT Takeshi KOBA	APPLICANT Takeshi KOBAYASHI, et al.					
(PTO-1449)				FILING DATE January 15, 200	FILING DATE January 15, 2004 GROUP 2818					
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1 Applicant: unique citation designation numble (optionize) 2 Applicant is to place a check mark here if English language Translation is attached.